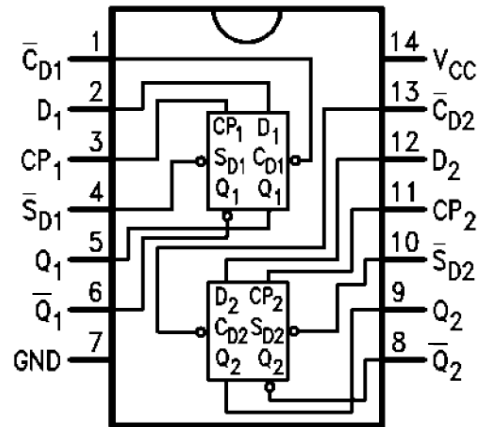
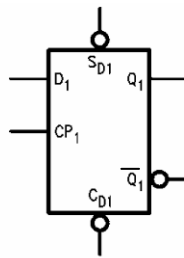


Laboratory 3: Flip-Flops

1. Use two 74LS00 NAND gates to create an “SR latch”. Use slider switches as inputs. Verify its truth table. The standard notation for a Q output that does not change is Q_0 . The “0” subscript implies that the current value is the same as the previous value. Now use an SPDT switch to “trigger” the latch as it falls from high to low (a *falling edge*). You should be able to see the SPDT switch output bouncing between the two states from the sliders if you slide one SLOWLY. Verify that putting switch through a latch “debounces” the switch.
2. Use two more 74LS00 NANDs and an inverter to create a clocked D-type latch. Verify its truth table.
3. Make another clocked SR latch from 74LS00 gates. Combine the two latches to make a master/slave edge-triggered flip-flop. Verify its truth table. Measure the propagation delay between the clock edge and when the data appears on Q . Measure the rise and fall times of the transitions on the output. Estimate the gate delay of a single TTL NAND. What do you think will be the maximum clock frequency that your device can handle? Explain.
4. Use a 74LS74 D-type edge-triggered flip-flop, construct a truth table, and compare its performance to your previous devices (e.g. the propagation delay). Note that this chip also has S and R inputs so you can set the state to a specific value. Also note the negative true nature of these inputs.

D-Type Edge-Triggered Flip-Flop

Inputs				Outputs	
\bar{S}_D	\bar{C}_D	CP	D	Q	\bar{Q}
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H	H
H	H	—	H	H	L
H	H	—	L	L	H
H	H	L	X	Q_0	\bar{Q}_0



Pin Names	Description
D_1, D_2	Data Inputs
CP_1, CP_2	Clock Pulse Inputs
$\bar{C}_{D1}, \bar{C}_{D2}$	Direct Clear Inputs
$\bar{S}_{D1}, \bar{S}_{D2}$	Direct Set Inputs
$Q_1, \bar{Q}_1, Q_2, \bar{Q}_2$	Outputs